WE HELP CUSTOMERS DELIVERING HIGH QUALITY FPGA-BASED PRODUCTS



KEY FACTS

- ③ 15+ years of innovation
- Output Patented technology
- O Users in 20+ countries

COMPETENCIES

- ③ Test & Measurement
- In Functional Test
- ITAG / IEEE 1149
- IJTAG / IEEE 1687
- Image: FPGA Design
- Section 2 Testability & DFT
- Embedded Test
- ⊗ BERT / HSIO Test
- Test Instrumentation
- O Boundary Scan
- I Flying Probe Test
- Ilectronics Design
- Sembedded Software
- Sault Management
- Service & Maintenance
- FPGA / SoC / MCUs
- O VHDL / Verilog

BUSINESS OVERVIEW

We have a deep and almost unbearable passion towards three things: FPGAs, testing, and innovation. Testonica invented and brought to market Embedded Virtual Instrumentation technology, a library of IEEE1687 reference benchmarks, and a pioneering IC health monitoring technology.

Today, thanks to over 15 years of industrial experience with hundreds of solutions delivered worldwide, we possess a huge in-house library of test & measurement instrumentation IPs forming a solid basis for a fully automated test system. Our everyday deep focus on FPGAs invites customers to order tailored FPGA-based designs of any kind. IJTAG-related IC DFT test access and network design is also our prime competence.

WE OFFER

- Functional test firmware and SW development
- OFT/IJTAG design/development services and consultancies
- FPGA design and product bring-up services
- ITAG / Boundary Scan test program development
- Test program development for Flying Probe testers
- Test strategy optimization and testability improvement
- Design of embedded systems: HW and SW
- System health monitoring and fault management solutions

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At Speed. Always

We take care of everyday test and development needs as well as challenging quality issues

Quick Defect Screening for

- O Prototyping
- O Production
- Clifetime
- Maintenance

DDR

EXPERTISE, SERVICES AND SOLUTIONS FACTSHEET



FPGA-BASED DEVELOPMENT

We have in-depth expertise in the following FPGA-based solutions and methodologies:

- VHDL and Verilog design languages
- High-Level Synthesis (HLS) methodology
- MD/Xilinx, Intel, Lattice, Microchip, Efinix
- ModelSim and QuestaSim simulators
- OhipScope, SignalTAP II, Reveal Analyzer
- Designing with SoC FPGA (ZynqUS+, Arria10)
- Designing with soft-processors from Xilinx (Microblaze) and Intel (NIOS II)
- High-speed design with multi-gigabit transceivers
- Buses: PCIe, SATA, AXI, Avalon, AXI-Lite
- Memory controllers: DDR3, DDR4
- Ethernet MAC interfaces, EtherCAT

EMBEDDED SW DEVELOPMENT

- Linux drivers and Userspace applications
- Bare-metal applications, bootloaders
- Embedded SDKs, ELDK
- Petalinux, Yocto, FreeRTOS, IwIP

ELECTRONICS / HARDWARE DESIGN

- O Digital electronics design and bring-up
- Analog and power electronics
- Preparation for production
- Sunctional and production test
- Prototype validation and certification
- OFT and test strategy optimization

TEST & MEASUREMENT, DFT ANALYSIS

Development of automated production test solutions and technologies is our core business. We help customers by contributing with:

- Functional Test & Measurement, Embedded Instrumentation (Quick Instruments)
- JTAG/Boundary Scan test development, deployment, support, training (Goepel)
- Flying Probe test program generation, deployment, support, training (Takaya)
- Board testability and DFT analysis with various test strategies and test methods: AOI, ICT, BST/JTAG, FPT, EFT etc. (TestWay Express)
- Handling Flying Probe and X-Ray inspection equipment incl. support and maintenance
- Repair station software handling: CAD viewer, fault tickets (QuadView)
- Test access procedures for IJTAG instruments, retargeting, ATE patterns, IJTAG network design, extraction and insertion (Tessent)
- FPGA-driven PCBA test using automatically generated test firmware (Quick Instruments)
- Processor-driven PCBA test and programming via JTAG (QITOS)
- Oltra-fast in-system flash programming
- Test and validation of gigabit links and highspeed interfaces
- At-speed testing of high-speed devices, DDR memories and interfaces
- Defect screening using stress / load / parametric test / BERT / FERT
- Fault tolerance, FDIR, and system health management

REFERENCE PROJECT EXAMPLES

- O Advantest: FPGA-based reference system for pre-silicon validation of a target IJTAG DFT infrastructure
- AST SpaceMobile: Functional and production test solution for an adaptive multiband satellite platform
- ③ CERN: Full-stack development from FPGA to GUI of custom Bit Error Rate Test equipment on FPGA for testing and certification of communication channels of LHC/CMS
- European Space Agency (ESA): 8-core processor on FPGA with integrated instant failure avoidance and health management system incl. optimized telemetry; applications for Xilinx Versal SoC FPGA
- European Spallation Source (ESS/ERIC): Embedded multi-board SoC-FPGA-based control system with high availability and remote management incl. custom-built EtherCAT FMC module
- ODZENS OF SMALLER SCALE ENGINEERING PROJECTS AND SOLUTION DELIVERIES IN THE RANGE OF 5-50K EUR

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